

# **CE EMC Test Report**

**Report No.:** CE190815D12

Test Model: SPC-4600

Series Model: SPC-4 XXXXXXXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing

purpose)

Received Date: Aug. 15, 2019

Test Date: Aug. 22 to Sep. 20, 2019

Issued Date: Oct. 7, 2019

Applicant: Vecow Co., Ltd.

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Report No.: CE190815D12 Page No. 1 / 73 Report Format Version: 6.1.3



# **Table of Contents**

Rel	ease Control Record	. 5
1	Certificate of Conformity	. 6
2	Summary of Test Results	. 7
2. 2.:	·	
3	General Information	
3.	1 Description of EUT	9
3.		
3.	1 0	
3.4 3.5		
4	Configuration and Connections with EUT	
4.	1 Connection Diagram of EUT and Peripheral Devices	12
4.	· · · · · · · · · · · · · · · · · · ·	
5	Conducted Emission from the AC Mains Power Port	16
5.	1 Limits	16
5.		
5.		
5.4	4 Test Results	18
6	Asymmetric Mode Conducted Emission at Telecommunication Ports	22
6.	1 Limits	22
6.		
6.		
6.4		
7	Radiated Emission at Frequencies up to 1GHz	
7.	1 Limits	
7.	2 Test Instruments	27
7.	2 Test Instruments	27 28
7.: 7.	2 Test Instruments 3 Test Arrangement 4 Test Results	27 28 29
7.5 7.6	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz	27 28 29 <b>31</b>
7.5 7.6 <b>8</b> 8.	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz	27 28 29 <b>31</b> 31
7.5 7.6 <b>8</b> 8.8.8	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments	27 28 29 <b>31</b> 31 32
7.5 7.6 <b>8</b> 8.	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement	27 28 29 <b>31</b> 31 32 33
7.5 7.6 <b>8</b> 8.8 8.8	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement	27 28 29 <b>31</b> 31 32 33 34
7.3 7.4 <b>8</b> 8.3 8.3 8.4	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement	27 28 29 <b>31</b> 31 32 33 34 <b>36</b>
7.3 7.4 8 8.3 8.3 8.4 9	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement  1 Limits	27 28 29 <b>31</b> 31 32 33 34 <b>36</b> 36
7.5 7.6 8.8.8 8.8 9.9 9.9	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement  1 Limits 2 Classification of Equipment 3 Test Instruments	27 28 29 <b>31</b> 31 32 33 34 <b>36</b> 36 36
7.3 7.4 8 8.8 8.8 8.9 9 9.9 9.9	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Instruments 6 Test Arrangement 7 Limits 7 Classification of Equipment 8 Test Arrangement	27 28 29 <b>31</b> 31 32 33 34 <b>36</b> 36 36 36 37
7 7 8 8 8 8 9 9 9 9	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement  1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Results	27 28 29 <b>31</b> 31 32 33 34 <b>36</b> 36 36 37 37
7.4 7.4 8 8.8.8.8 9 9.9.9.9 9.1	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Arrangement 7 Test Arrangement 8 Test Arrangement 9 Test Arrangement 9 Test Arrangement 9 Test Results	27 28 29 <b>31</b> 31 32 33 34 <b>36</b> 36 36 37 37
7 7 8 8 8 9 9 9 9 9	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Arrangement 5 Test Results  Voltage Fluctuations and Flicker Measurement  1 Limits	27 28 29 <b>31</b> 31 32 33 34 <b>36</b> 36 36 37 37 <b>38</b>
7 7 8 8 8 9 9 9 9 9	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Results  Voltage Fluctuations and Flicker Measurement  0.1 Limits 0.2 Test Instruments	27 28 29 <b>31</b> 31 32 33 34 <b>36</b> 36 36 37 37 <b>38</b> 38
7 7 8 8 8 9 9 9 9 9	2 Test Instruments 3 Test Arrangement 4 Test Results  Radiated Emission at Frequencies above 1GHz  1 Limits 2 Test Instruments 3 Test Arrangement 4 Test Results  Harmonics Current Measurement 1 Limits 2 Classification of Equipment 3 Test Instruments 4 Test Arrangement 5 Test Arrangement 5 Test Results  Voltage Fluctuations and Flicker Measurement  1 Limits	27 28 29 31 31 32 33 34 36 36 36 37 37 38 38 38



11	General Immunity Requirements	. 40
11.	1 Performance Criteria	41
12	Electrostatic Discharge Immunity Test (ESD)	. 42
12.	1 Test Specification	42
12.	2 Test Instruments	42
12.	3 Test Arrangement	42
12.	4 Test Results	44
13	Radiated, Radio-frequency, Electromagnetic Field Immunity Test (RS)	. 48
13.	1 Test Specification	48
13.	2 Test Instruments	48
13.		
13.	4 Test Results	50
14	Electrical Fast Transient/Burst Immunity Test (EFT)	. 51
14.	1 Test Specification	51
14.	2 Test Instruments	51
14.		
14.	4 Test Results	52
15	Surge Immunity Test	. 53
15.	1 Test Specification	53
15.	2 Test Instruments	53
15.	3 Test Arrangement	54
15.	4 Test Results	55
16	Immunity to Conducted Disturbances Induced by RF Fields (CS)	. 56
16.	1 Test Specification	56
16.	2 Test Instruments	56
16.	<b>5</b>	
16.	4 Test Results	58
17	Power Frequency Magnetic Field Immunity Test	. 59
17.	1 Test Specification	59
17.		
17.	g ·	59
17.	4 Test Results	60
18	Voltage Dips and Interruptions	. 61
18.	1 Test Specification	61
18.	2 Test Instruments	61
18.		
18.	4 Test Results	62
19	Pictures of Test Arrangements	. 63
19.	1 Conducted Emission from the AC Mains Power Port	63
19.	2 Asymmetric Mode Conducted Emission at Telecommunication Ports	64
19.		65
19.		
19.	5 Harmonics Current, Voltage Fluctuations and Flicker Measurement	67
19.		
19.		
19.	, ,	
19.		
19.		
19.	11 Power Frequency Magnetic Field Immunity Test (PFMF)	72



19.12 Voltage Dips and Interruptions  ppendix – Information of the Testing Laboratories	



# **Release Control Record**

Issue No.	Description	Date Issued
CE190815D12	Original release.	Oct. 7, 2019



## 1 Certificate of Conformity

Product: SPC-4600 series

Brand: Vecow

Test Model: SPC-4600

**Series Model:** SPC-4 XXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)

Sample Status: Engineering sample

Applicant: Vecow Co., Ltd.

**Test Date:** Aug. 22 to Sep. 20, 2019

Standards: EN 55032:2015 +AC:2016, Class A

EN 61000-3-2:2014 EN 61000-3-3:2013

EN 55024:2010 / EN55024:2010 +A1:2015

EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0

EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2

EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0

EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0

EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED. 4.0

EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0

EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by: Oct. 7, 2019

Vivian Chen / Specialist

Jim Hsiang / Associate Technical Manager



# 2 Summary of Test Results

Emission				
Standard	Test Item	Result/Remarks	Verdict	
	Conducted emission from the AC mains power port	Minimum passing Class A margin is -7.66 dB at 9.10938 MHz	Pass	
EN 55032:2015 +AC:2016	Asymmetric mode conducted emission at telecommunication ports	Minimum passing Class A margin is -5.65 dB at 0.50028 MHz	Pass	
	Radiated emission 30-1000 MHz	Minimum passing Class A margin is -3.23 dB at 924.86 MHz	Pass	
	Radiated emission above 1GHz	Minimum passing Class A margin is -5.48 dB at 1539.90 MHz	Pass	
EN 61000-3-2:2014	Harmonic current emissions	The power consumption of EUT is less than 75W and no limits apply.	Pass	
EN 61000-3-3:2013	Voltage fluctuations and flicker	$\begin{array}{ll} P_{st} \leqq 1.0 & d_{max} \leqq 4\% \\ P_{lt} \leqq 0.65 & d_c \leqq 3.3\% \\ T_{max} \leqq 500ms \end{array}$	Pass	

Immunity					
EN 55024 Clause	Basic standard	Test Item	Result/Remarks	Verdict	
4.2.1	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0	Electrostatic discharges (ESD)	Performance Criterion B	Pass	
4.2.3.2	EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2	Continuous radiated disturbances (RS)	Performance Criterion A	Pass	
4.2.2	EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0	Electrical fast transients (EFT)	Performance Criterion A	Pass	
4.2.5	EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2014 +A1:2017 ED. 3.0	Surges	Performance Criterion A	Pass	
4.2.3.3	EN 61000-4-6:2014 +AC:2015 / IEC 61000-4-6:2013 ED. 4.0	Continuous conducted disturbances (CS)	Performance Criterion A	Pass	
4.2.4	EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0	Power-frequency magnetic fields (PFMF)	Performance Criterion A	Pass	
4.2.6	EN 61000-4-11:2004 +A1:2017 / IEC 61000-4-11:2004 +A1:2017 ED. 2.0	Voltage dips and interruptions	Voltage Dips: >95% reduction – 0.5 period, Performance Criterion A 30% reduction – 25 periods, Performance Criterion A Voltage Interruptions: >95% reduction – 250 periods, Performance Criterion B	Pass	

## Note:

- 1. There is no deviation to the applied test methods and requirements covered by the scope of this report.
- 2. The above EN/IEC basic standards are applied with latest version if customer has no special requirement.
- 3. Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.



# 2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expended Uncertainty (k=2) (±)	Maximum allowable uncertainty (±)
Conducted emission from AC mains power port using AMN, 150kHz ~ 30MHz	2.79 dB	3.4 dB ( <i>U</i> cispr)
Asymmetric mode conducted emission using AAN, 150kHz ~ 30MHz	3.94 dB	5.0 dB ( <i>U</i> cispr)
Radiated emission, 30MHz ~ 1GHz	4.02 dB	6.3 dB ( <i>U</i> <sub>cispr</sub> )
Radiated emission, 1GHz ~ 6GHz	5.18 dB	5.2 dB ( <i>U</i> <sub>cispr</sub> )

# 2.2 Modification Record

	There were	no modifications	required for	compliance.
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### 3 General Information

## 3.1 Description of EUT

Product	SPC-4600 series
Brand	Vecow
Test Model	SPC-4600
Series Model	SPC-4 XXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purpose)
Model Difference	Marketing Differentiation
Sample Status	Engineering sample
Operating Software	Windows 10
Power Supply Rating	DC 9V to 36V from adapter
Accessory Device	Adapter
Data Cable Supplied	N/A

### Note:

- 1. The EUT is a SPC-4600 series with following interfaces:
  - ♦ COM \*4 (RS-232/422/485)
  - ♦ USB 3.0\*4
  - ♦ Isolated DIO
  - ♦ Display (resolution up to 4096 x 2160 @ 60Hz)
  - ♦ DVI-I (resolution up to 3840 x 2160 @ 60Hz)
  - ♦ PoE LAN\*2 (10/100Mbps)
  - ♦ Audio out
  - ♦ IGN
  - ♦ DC input

# 2. The EUT uses following adapter.

Brand	MEAN WELL
Model	GST160A24
Input Power	100-240Vac, 50/60Hz, 2.0A
Output Power	24V, 6.67A, 160W
Power Line	Non-shielded DC (1.2m) with one ferrite core

### 3.2 Features of EUT

- 1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.
- 2. The EUT was configured with the following key components:

Processor	Intel Atom® x7-E3950 Processor (Apollo Lake-I)
BIOS	AMI
SIO	IT8786E
Memory	1 DDR3L 1866MHz SO-DIMM, up to 8GB
OS	Windows 10, Linux



# 3.3 Operating Modes of EUT and Determination of Worst Case Operating Mode

- 1. The EUT was pre-tested under operating and standby condition and the worst emission level was found under **operating condition**.
- 2. The EUT is designed with AC power of rating 100-240Vac, 50/60Hz.

  For radiated emission evaluation, 230Vac/ 50Hz & 110Vac/ 60Hz had been covered during the pre-test.

  The worst data was found at 110Vac/ 60Hz and recorded in the applied test report.
- 3. Test modes are presented in the report as below.

Mode	Test Condition	Input Power		
	Conducted emission test			
1	Full evetem Dieploy (2490 x 2460 @ 60H=) <note> LDVI (4020 x 4200 @ 60H=) <note></note></note>	230Vac/ 50Hz &		
ı	Full system, Display (3480 x 2160 @ 60Hz) <note> + DVI (1920 x 1200 @ 60Hz) <note></note></note>	110Vac/ 60Hz		
	Asymmetric mode conducted emission at telecommunication ports			
1	Full system, Display (3480 x 2160 @ 60Hz) <note> + DVI (1920 x 1200 @ 60Hz) <note> -</note></note>			
ı	PoE LAN port 1, 100Mbps	220\/c.c// E01.1=		
0	Full system, Display (3480 x 2160 @ 60Hz) <note> + DVI (1920 x 1200 @ 60Hz) <note> -</note></note>	230Vac/ 50Hz		
2	PoE LAN port 2, 100Mbps			

The idle mode of conducted emission test at telecom port was pre-tested based on the worst case of link mode. Due to emissions of idle mode being very low compared to link mode, only the link mode data were presented in the test report.

	Radiated emission test									
1	Full system, Display (3480 x 2160 @ 60Hz) < DVI (1920 x 1200 @ 60Hz) < Note >	110Vac/ 60Hz								
	Harmonics, Flicker, Immunity tests									
1	Full system, Display (3480 x 2160 @ 60Hz) < DVI (1920 x 1200 @ 60Hz) < Note >	230Vac/ 50Hz								

Note: The general maximum resolution of the external display monitor is 1920x 1200 @ 60Hz. (for DVI) and 3480 x 2160 @ 60Hz (for Display).

Report No.: CE190815D12 Page No. 10 / 73 Report Format Version: 6.1.3



### 3.4 Test Program Used and Operation Descriptions

### Emission tests (Harmonics & Flicker excluded):

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. HDD.
- d. Network Cameras (kept in a remote area) captured messages to EUT via two STP LAN cables (each 10m).
- e. EUT sent "color bars with moving element" messages to ext. LCD Monitors. Then they displayed "color bars with moving element" messages on their screens simultaneously.
- f. EUT sent 1kHz audio signal to earphone.
- g. EUT sent messages to printer and printer printed them out.
- h. Steps c-g were repeated.

### Harmonics, Flicker, Immunity tests:

- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and USB Disk.
- d. Network Cameras (kept in a remote area) captured messages to EUT via two STP LAN cables (each 10m).
- e. EUT sent "H" messages to ext. LCD Monitors. Then they displayed "H" messages on their screens simultaneously.
- f. EUT sent 1kHz audio signal to speaker.
- g. Steps c-f were repeated.

# 3.5 Primary Clock Frequencies of Internal Source

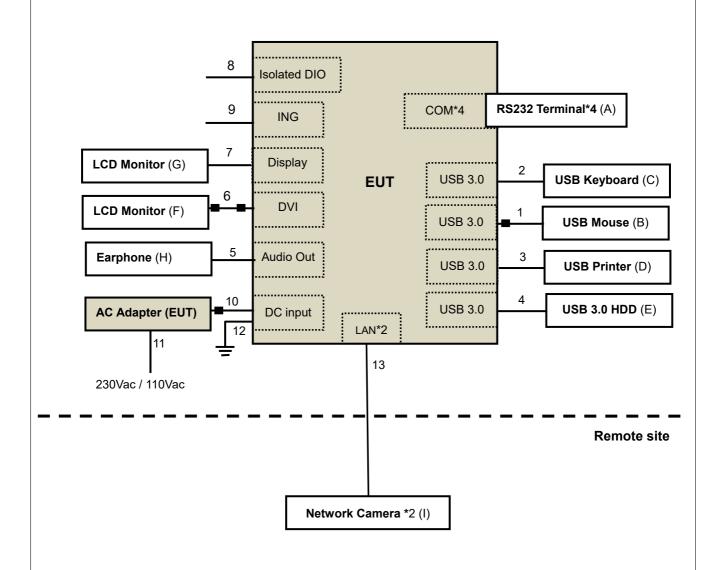
The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 1600MHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.



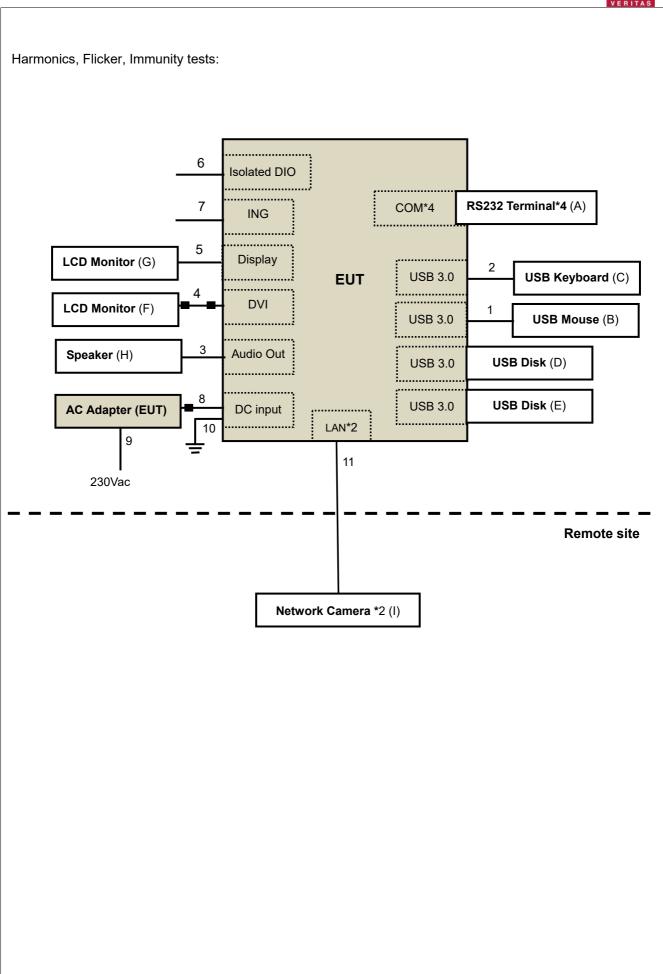
## 4 Configuration and Connections with EUT

## 4.1 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):









# 4.2 Configuration of Peripheral Devices and Cable Connections

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	RS232 Terminal*4	N/A	N/A	N/A N/A		Supplied by client
B.	USB Mouse	Microsoft	1113	9170528318308	FCC DoC Approved	Provided by Lab
C.	USB KEYBOARD	Dell	KB216t	CN-0W33XP-LO300- 7CL-190A	FCC DoC Approved	Provided by Lab
D.	Printer	HP	Officejet pro 251dw	CN55FCV012	B94SDGOB1191	Provided by Lab
E.	USB-C Hard Disk	G-DRIVE	0G04878	620XJ6RW	FCC DoC Approved	Provided by Lab
F.	24" LCD MONITOR	DELL	U2410	CN082WXD728720 CC0UHL	FCC DoC Approved	Provided by Lab
G.	LCD Monitor	ASUS	MG28UQ	H8LMTF147978	FCC DoC Approved	Provided by Lab
H.	EARPHONE	PHILIPS	SBC HL145	N/A	N/A	Provided by Lab
1.	Network Camera*2	3MP	A301RZ-0309P	T42211286/278	N/A	Supplied by client

### Note:

- 1. All power cords of the above support units are non-shielded (1.8m).
- 2. Item I acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	USB cable	1	1.8	Υ	1	Provided by Lab
2.	USB cable	1	1.8	Υ	0	Provided by Lab
3.	USB cable	1	1.8	Υ	0	Provided by Lab
4.	USB cable	1	0.5	Υ	0	Provided by Lab
5.	Audio cable	1	1.2	N	0	Provided by Lab
6.	DVI cable	1	1.8	Υ	2	Provided by Lab
7.	Display cable	1	1.8	Υ	0	Provided by Lab
8.	DIO cable	1	0.9	N	0	Supplied by client
9.	Signal cable	1	1.8	N	0	Supplied by client
10.	DC power power	1	1.2	N	1	Supplied by client
11.	AC power cord	1	1.8	N	0	Provided by Lab
12.	GND cable	1	2.0	N	0	Supplied by client
13.	LAN cable	2	10	Y	0	Provided by Lab (RJ45, Cat.5e)

Note: The core(s) is(are) originally attached to the cable(s).



Harmonics, Flicker, Immunity tests:

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	RS232 Terminal*4	N/A	N/A	N/A	N/A	Supplied by client
B.	USB Mouse	HP	KU-1156	N/A	FCC DoC Approved	Provided by Lab
C.	USB KEYBOARD	HP	MOFYUO	N/A	FCC DoC Approved	Provided by Lab
D.	USB Disk	SP	16GB	N/A	N/A	Provided by Lab
E.	USB Disk	SP	16GB	N/A	N/A	Provided by Lab
	24" LCD MONITOR	DELL	U2412M	CN-07N2FG-TV100- 7BG-039L	FCC DoC Approved	Provided by Lab
F.	LCD MONITOR (Only RS test)	AOC	U2868PQU	HCXE8JA000360	FCC DoC Approved	Provided by Lab
	LCD MONITOR	DELL	P2415Qb	CN-OGTTPW-74261 -662-OAGL	FCC DoC Approved	Provided by Lab
G.	24" LCD MONITOR (Only RS test)	AOC	240LM00016	GKAJ5HA117785	FCC DoC Approved	Provided by Lab
H.	Speaker	N/A	N/A	N/A	N/A	Provided by Lab
I.	Network Camera*2	3MP	A301RZ-0309P	T42211286/278	N/A	Supplied by client

### Note:

- 1. All power cords of the above support units are non-shielded (1.8m).
- 2. Item I acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	USB cable	1	1.8	Υ	0	Provided by Lab
2.	USB cable	1	1.8	Υ	0	Provided by Lab
3.	Audio cable	1	1.2	N	0	Provided by Lab
4.	DVI cable	1	1.8	Υ	2	Provided by Lab
5.	Display cable	1	1.8	Υ	0	Provided by Lab
6.	DIO cable	1	0.9	N	0	Supplied by client
7.	Signal cable	1	1.8	N	0	Supplied by client
8.	DC power power	1	1.2	N	1	Supplied by client
9.	AC power cord	1	1.8	N	0	Provided by Lab
10.	GND cable	1	2.0	N	0	Supplied by client
11.	LAN cable	2	10	N	0	Provided by Lab (RJ45, Cat.5e)

Note: The core(s) is(are) originally attached to the cable(s).



## 5 Conducted Emission from the AC Mains Power Port

## 5.1 Limits

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Class A limits (dBuV)
0.15 - 0.5		Quasi-peak / 9kHz	79
0.5 - 30.0	AMNI	Quasi-peak / 9kHz	73
0.15 - 0.5	AMN	Average / OkHz	66
0.5 - 30.0		Average / 9kHz	60

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Class B limits (dBuV)
0.15 - 0.5	-		66 - 56
0.5 - 5		Quasi-peak / 9kHz	56
5 - 30.0	AMN		60
0.15 - 0.5	Alviin		56 - 46
0.5 - 5		Average / 9kHz	46
5 - 30.0			50

## 5.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due	
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100290	Dec. 18, 2018	Dec. 17, 2019	
ROHDE & SCHWARZ Artificial Mains Network (for EUT)	ENV216	101197	Jun. 5, 2019	Jun. 4, 2020	
LISN With Adapter (for EUT)	101197	NA	Jun. 5, 2019	Jun. 4, 2020	
ROHDE & SCHWARZ					
Artificial Mains Network	ESH3-Z5	100218	Nov. 30, 2018	Nov. 29, 2019	
(for peripherals)					
SCHWARZBECK	NNLK8129	8129229	May 14, 2019	May 13, 2020	
Artificial Mains Network (For EUT)	MINLINGIZS	0129229	Way 14, 2019	Way 10, 2020	
SCHWARZBECK	NNLK 8121	8121-808	Mar. 15, 2019	Mar. 14, 2020	
Artificial Mains Network (For EUT)	ININLIX 0121	0121-000	IVIAI. 13, 2019	IVIAI. 14, 2020	
Software	Cond_V7.3.7.4	NA	NA	NA	
RF cable (JYEBAO)	ED ED	Cable-C10.01	Feb. 13, 2019	Feb. 12, 2020	
With 10dB PAD	5D-FB	Cable-C10.01	reb. 13, 2019	Feb. 12, 2020	
LYNICS Terminator (For ROHDE & SCHWARZ LISN)	0900510	E1-011484	May 13, 2019	May 12, 2020	
ROHDE & SCHWARZ	ENV216	101196	Apr 16 2010	Apr 15 2020	
Artificial Mains Network (For TV EUT)	EINVZIO	101190	Apr. 16, 2019	Apr. 15, 2020	
LISN With Adapter (for TV EUT)	101196	NA	Apr. 16, 2019	Apr. 15, 2020	

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

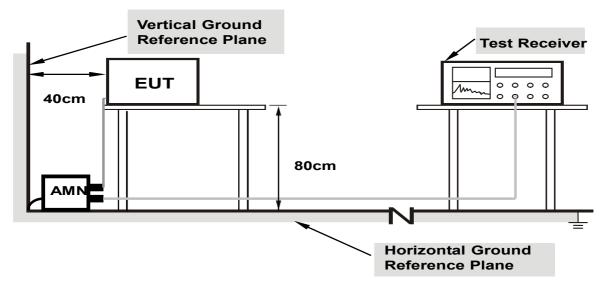
- 2. The test was performed in Shielded Room No. 10.
- 3. The VCCI Site Registration No. C-11852.
- 4. Tested Date: Aug. 22, 2019



### 5.3 Test Arrangement

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through an Artificial Mains Network (AMN). Other support units were connected to the power mains through another AMN. The two AMNs provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The test results of conducted emissions at mains ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



- Note: 1. Support units were connected to second AMN.
  - The distance specified between EUT/AE and other metallic objects is ≥ 0.8 m in the measurement arrangement for table-top EUT.
  - 3. Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

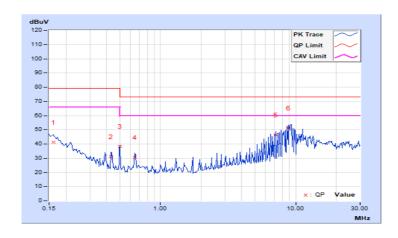


## 5.4 Test Results

Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz	Environmental Conditions	25°C, 75%RH, 995mbar
Tested by	Vincent Lin		
Test Mode	Mode 1		

	Phase Of Power : Line (L)											
No	Frequency	Correction Factor		Reading Value (dBuV)		n Level uV)		nit uV)		gin B)		
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.		
1	0.16172	9.64	31.69	19.22	41.33	28.86	79.00	66.00	-37.67	-37.14		
2	0.43125	9.67	21.39	21.15	31.06	30.82	79.00	66.00	-47.94	-35.18		
3	0.50156	9.68	28.57	27.80	38.25	37.48	73.00	60.00	-34.75	-22.52		
4	0.65000	9.70	20.88	20.45	30.58	30.15	73.00	60.00	-42.42	-29.85		
5	7.15625	9.87	36.77	36.63	46.64	46.50	73.00	60.00	-26.36	-13.50		
6	8.89063	9.91	41.50	41.21	51.41	51.12	73.00	60.00	-21.59	-8.88		

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

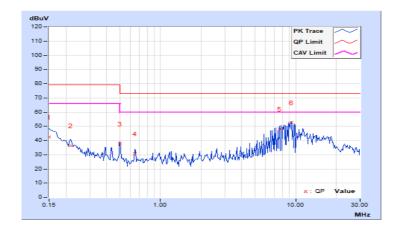




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz	Environmental Conditions	25°C, 75%RH, 995mbar
Tested by	Vincent Lin		
Test Mode	Mode 1		

	Phase Of Power : Neutral (N)													
No	Frequency	Correction Factor		Reading Value (dBuV)		Reading Value (dBuV)		•		n Level uV)			Margin (dB)	
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.				
1	0.15000	9.66	32.68	26.71	42.34	36.37	79.00	66.00	-36.66	-29.63				
2	0.21641	9.67	26.67	24.38	36.34	34.05	79.00	66.00	-42.66	-31.95				
3	0.50156	9.71	27.86	26.97	37.57	36.68	73.00	60.00	-35.43	-23.32				
4	0.65000	9.73	20.86	20.11	30.59	29.84	73.00	60.00	-42.41	-30.16				
5	7.58984	9.91	38.34	36.51	48.25	46.42	73.00	60.00	-24.75	-13.58				
6	9.32422	9.95	42.44	41.89	52.39	51.84	73.00	60.00	-20.61	-8.16				

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

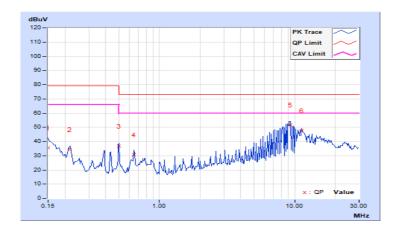




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	25°C, 75%RH, 995mbar
Tested by	Vincent Lin		
Test Mode	Mode 1		

	Phase Of Power : Line (L)									
No	Frequency	Correction Factor	•			rgin B)				
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15000	9.63	25.89	17.19	35.52	26.82	79.00	66.00	-43.48	-39.18
2	0.21641	9.65	24.58	23.76	34.23	33.41	79.00	66.00	-44.77	-32.59
3	0.50156	9.68	26.98	26.16	36.66	35.84	73.00	60.00	-36.34	-24.16
4	0.65000	9.70	21.10	20.49	30.80	30.19	73.00	60.00	-42.20	-29.81
5	9.32422	9.92	41.63	41.44	51.55	51.36	73.00	60.00	-21.45	-8.64
6	11.26172	9.94	37.77	37.76	47.71	47.70	73.00	60.00	-25.29	-12.30

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

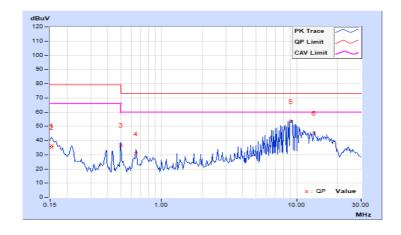




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	25°C, 75%RH, 995mbar
Tested by	Vincent Lin		
Test Mode	Mode 1		

	Phase Of Power : Neutral (N)									
No	Frequency	Correction Factor				rgin B)				
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15391	9.67	26.78	18.66	36.45	28.33	79.00	66.00	-42.55	-37.67
2	0.15391	9.67	25.52	18.64	35.19	28.31	79.00	66.00	-43.81	-37.69
3	0.50156	9.71	27.14	26.37	36.85	36.08	73.00	60.00	-36.15	-23.92
4	0.65000	9.73	20.92	20.13	30.65	29.86	73.00	60.00	-42.35	-30.14
5	9.10938	9.95	43.24	42.39	53.19	52.34	73.00	60.00	-19.81	-7.66
6	13.39844	10.01	35.28	35.24	45.29	45.25	73.00	60.00	-27.71	-14.75

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





# **6** Asymmetric Mode Conducted Emission at Telecommunication Ports

# 6.1 Limits

# For Class A Equipment

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Voltage limits (dBuV)	Current limits (dBuA)
0.15 - 0.5	AAN	Quasi-peak / 9kHz	97 – 87	
0.5 - 30.0	AAN	Quasi-peak / 9ki iz	87	N/A
0.15 - 0.5	AAN	Average / 9kHz	84-74	IN/A
0.5 - 30.0	AAN	Average / 9Ki iz	74	
0.15 - 0.5	CVP	Ouggi pook / OkHz	97 – 87	53 – 43
0.5 - 30.0	and current probe	Quasi-peak / 9kHz	87	43
0.15 - 0.5	CVP	Average / 9kHz	84-74	40 – 30
0.5 - 30.0	and current probe	Average / 9km2	74	30
0.15 - 0.5	Current Probe	Ougoi pook / OkHz		53 – 43
0.5 - 30.0	Current Probe	Quasi-peak / 9kHz	N/A	43
0.15 - 0.5	Current Probe	Average / 9kHz	IN/A	40 – 30
0.5 - 30.0	Current Prope	Average / 9KHZ		30

# For Class B Equipment

Frequency range (MHz)	Coupling device	Detector type / bandwidth	Voltage limits (dBuV)	Current limits (dBuA)
0.15 - 0.5	AAN	Ougoi pook / OkHz	84 – 74	
0.5 - 30.0	AAN	Quasi-peak / 9kHz	74	N/A
0.15 - 0.5	AAN	Average / OkHz	74-64	IN/A
0.5 - 30.0	AAN	Average / 9kHz	64	
0.15 - 0.5	CVP	Ougoi poek / OkUz	84 – 74	40 – 30
0.5 - 30.0	and current probe	Quasi-peak / 9kHz	74	30
0.15 - 0.5	CVP	Average / OkHz	74-64	30 – 20
0.5 - 30.0	and current probe	Average / 9kHz	64	20
0.15 - 0.5	Current Drobe	Ougai magk / Okl I=		40 – 30
0.5 - 30.0	Current Probe	Quasi-peak / 9kHz	N/A	30
0.15 - 0.5	Current Probe	Average / 9kHz	IN/A	30 – 20
0.5 - 30.0	Current Probe	Average / 9kmz		20



### 6.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100290	Dec. 18, 2018	Dec. 17, 2019
ROHDE & SCHWARZ Artificial Mains Network (for EUT)	ENV216	101197	Jun. 5, 2019	Jun. 4, 2020
LISN With Adapter (for EUT)	101197	NA	Jun. 5, 2019	Jun. 4, 2020
ROHDE & SCHWARZ Artificial Mains Network (for peripherals)	ESH3-Z5	100218	Nov. 30, 2018	Nov. 29, 2019
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 14, 2019	May 13, 2020
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK 8121	8121-808	Mar. 15, 2019	Mar. 14, 2020
Software	Cond_V7.3.7.4	NA	NA	NA
Software	ISN_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO) With 10dB PAD	5D-FB	Cable-C10.01	Feb. 13, 2019	Feb. 12, 2020
LYNICS Terminator (For ROHDE & SCHWARZ LISN)	0900510	E1-011484	May 13, 2019	May 12, 2020
TESEQ ISN	ISN ST08	41212	Jul. 31, 2019	Jul. 30, 2020

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Shielded Room No. 10.
- 3. The VCCI Site Registration No. T-11611.
- 4. Tested Date: Aug. 27, 2019

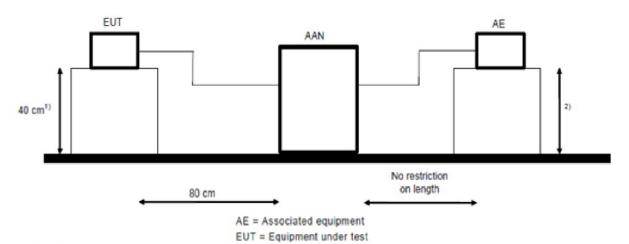


### 6.3 Test Arrangement

### **Method of Using AANs:**

- a. The EUT is placed 0.4 meters from the conducting wall of the shielded room and connected to AAN directly to reference ground plane.
- b. If voltage measurement is used, measure voltage at the measurement port of the AAN, correct the reading by adding the AAN voltage division factor, and compare to the voltage limit.
- c. It is not necessary to apply the voltage and the current limit if a AAN is used.
- d. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



- 1) Distance to the reference groundplane (vertical or horizontal).
- 2) Distance to the reference groundplane is not critical.

Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

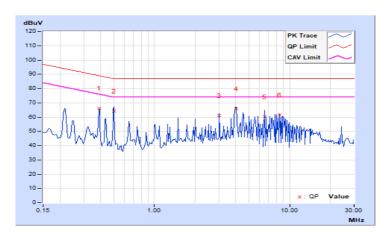


## 6.4 Test Results

Erogueney Benge	150kHz ~ 30MHz	<b>Detector Function &amp;</b>	Quasi-Peak (QP) /	
Frequency Range	150KH2 ~ 30WH2	Bandwidth	Average (AV), 9kHz	
Input Power	230Vac, 50Hz	Environmental	25°C, 75%RH, 995mbar	
input Power	250 vac, 501 12	Conditions	25 C, 75 %KH, 995Hbal	
Tested by	Vincent Lin			
Toot Mode 1				
Test Mode RJ45 TELECOM PORT 1 (100Mbps, TFGEN+PING)				

No	Frequency	Correction Factor		g Value uV)	Emissio (dB	n Level uV)		nit uV)	Maı (d	•
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.39092	9.92	56.33	56.28	66.25	66.20	89.04	76.04	-22.79	-9.84
2	0.50156	9.92	54.16	51.61	64.08	61.53	87.00	74.00	-22.92	-12.47
3	3.00391	10.01	50.97	50.43	60.98	60.44	87.00	74.00	-26.02	-13.56
4	4.00526	10.05	55.93	55.84	65.98	65.89	87.00	74.00	-21.02	-8.11
5	6.50391	10.15	50.18	47.09	60.33	57.24	87.00	74.00	-26.67	-16.76
6	8.45313	10.23	51.05	50.59	61.28	60.82	87.00	74.00	-25.72	-13.18

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value

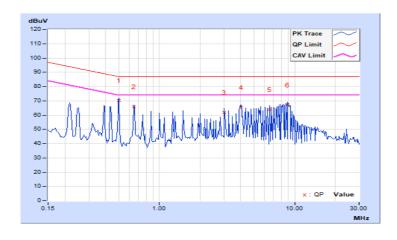




Frequency Range	150kHz ~ 30MHz	Detector Function & Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	230Vac, 50Hz	Environmental Conditions	25°C, 75%RH, 995mbar
Tested by	Vincent Lin		
Test Mode	Mode 2 RJ45 TELECOM PORT 2 (	100Mbps, TFGEN+PING)	

No	Frequency	Correction Factor		g Value uV)		on Level uV)		nit suV)		gin B)
	(MHz)	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.50028	9.92	60.51	58.43	70.43	68.35	87.00	74.00	-16.57	-5.65
2	0.65000	9.92	55.99	55.96	65.91	65.88	87.00	74.00	-21.09	-8.12
3	3.00391	10.01	52.01	50.45	62.02	60.46	87.00	74.00	-24.98	-13.54
4	4.00781	10.05	55.22	55.17	65.27	65.22	87.00	74.00	-21.73	-8.78
5	6.50391	10.15	53.49	51.27	63.64	61.42	87.00	74.00	-23.36	-12.58
6	8.88927	10.25	56.71	55.99	66.96	66.24	87.00	74.00	-20.04	-7.76

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value





# 7 Radiated Emission at Frequencies up to 1GHz

# 7.1 Limits

# For Class A Equipment

Frequency range (MHz)	Distance (m)	Limits (dBuV/m)
30 - 230	10	40
230 - 1000	10	47
30 - 230	2	50
230 - 1000	3	57

# For Class B Equipment

Frequency range (MHz)	Distance (m)	Limits (dBuV/m)
30 - 230	10	30
230 - 1000	10	37
30 - 230	2	40
230 - 1000	3	47

### 7.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100027	May 13, 2019	May 12, 2020
Schwarzbeck Bilog Antenna	VULB9168	9168-303	Nov. 22, 2018	Nov. 21, 2019
Agilent Preamplifier	8447D	2944A08119	Feb. 20, 2019	Feb. 19, 2020
ADT. Turn Table	TT100	0205	NA	NA
ADT. Tower	AT100	0205	NA	NA
Software	Radiated_V7.6.15.9.5	NA	NA	NA
ADT RF Switches BOX	EMH-011	1001	Oct. 25, 2018	Oct. 24, 2019
Pacific RF cable With 5dB PAD	8D	CABLE-ST2-01	Oct. 25, 2018	Oct. 24, 2019

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Open Site No. 2.
- 3. The VCCI Site Registration No. R-237.
- 4. Tested Date: Aug. 28, 2019

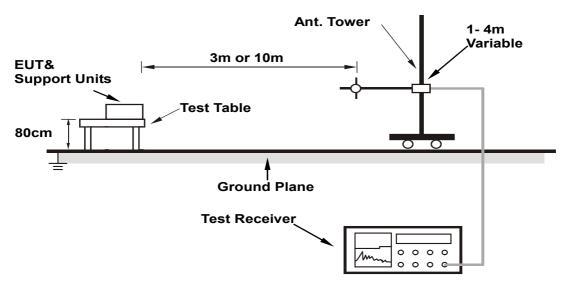


## 7.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited test facility. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 10 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

#### Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

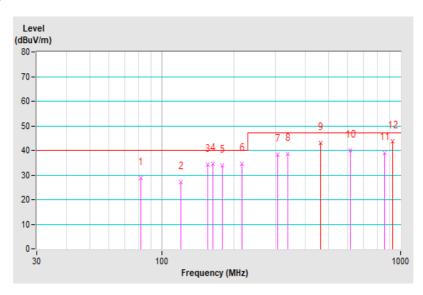


## 7.4 Test Results

Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Vhenson Huang	Environmental Conditions	30℃, 55%RH, 1002mbar
Test Mode	Mode 1		

	Antenna Polarity & Test Distance : Horizontal at 10 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	81.84	28.94 QP	40.00	-11.06	4.00 H	182	44.45	-15.51		
2	120.14	27.26 QP	40.00	-12.74	4.00 H	122	39.50	-12.24		
3	155.62	34.32 QP	40.00	-5.68	4.00 H	145	44.43	-10.11		
4	163.54	34.62 QP	40.00	-5.38	4.00 H	125	44.78	-10.16		
5	179.90	33.90 QP	40.00	-6.10	4.00 H	152	45.39	-11.49		
6	216.27	34.50 QP	40.00	-5.50	4.00 H	207	46.90	-12.40		
7	304.67	38.30 QP	47.00	-8.70	2.91 H	172	47.21	-8.91		
8	337.55	38.77 QP	47.00	-8.23	2.92 H	156	46.94	-8.17		
9	462.43	42.95 QP	47.00	-4.05	2.41 H	338	48.67	-5.72		
10	616.60	40.08 QP	47.00	-6.92	1.87 H	104	42.12	-2.04		
11	856.75	38.96 QP	47.00	-8.04	1.00 H	156	36.27	2.69		
12	924.86	43.77 QP	47.00	-3.23	1.00 H	10	39.41	4.36		

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
  - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value

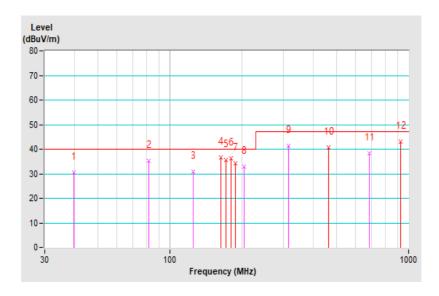




Frequency Range	30MHz ~ 1GHz	Detector Function & Bandwidth	Quasi-Peak (QP), 120kHz
Tested by	Vhenson Huang	Environmental Conditions	30°C, 55%RH, 1002mbar
Test Mode	Mode 1		

	Antenna Polarity & Test Distance : Vertical at 10 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	39.72	30.56 QP	40.00	-9.44	1.02 V	22	41.40	-10.84		
2	81.89	35.25 QP	40.00	-4.75	1.00 V	22	50.77	-15.52		
3	125.05	30.69 QP	40.00	-9.31	1.00 V	100	42.38	-11.69		
4	163.81	36.69 QP	40.00	-3.31	1.00 V	201	46.84	-10.15		
5	172.01	35.44 QP	40.00	-4.56	1.00 V	181	46.00	-10.56		
6	180.22	36.11 QP	40.00	-3.89	1.00 V	5	47.65	-11.54		
7	188.44	34.15 QP	40.00	-5.85	1.00 V	22	46.59	-12.44		
8	204.84	32.82 QP	40.00	-7.18	1.00 V	303	45.43	-12.61		
9	313.31	41.39 QP	47.00	-5.61	1.00 V	184	50.00	-8.61		
10	462.43	40.56 QP	47.00	-6.44	2.80 V	173	46.28	-5.72		
11	685.09	38.36 QP	47.00	-8.64	2.43 V	143	39.24	-0.88		
12	924.86	43.21 QP	47.00	-3.79	2.43 V	7	38.85	4.36		

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
  - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





## 8 Radiated Emission at Frequencies above 1GHz

### 8.1 Limits

For Class A Equipment

Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)
1000 - 3000		Averege	56
3000 - 6000	3	Average	60
1000 - 3000		Peak	76
3000 - 6000		reak	80

## For Class B Equipment

Frequency range (MHz)	Distance (m)	Detector type	Limits (dBuV/m)
1000 - 3000		Average	50
3000 - 6000	3	Average	54
1000 - 3000		Peak	70
3000 - 6000		reak	74

Required highest frequency for radiated measurement

· · · · · · · · · · · · · · · · · · ·					
Highest internal frequency (F <sub>x</sub> )	Highest measured frequency				
$F_x \leq 108  MHz$	1 GHz				
$108~\text{MHz}~<~F_x~\leqq~500~\text{MHz}$	2 GHz				
$500 \text{ MHz} < F_x \le 1 \text{ GHz}$	5 GHz				
$F_x > 1 \text{ GHz}$	5 x F <sub>x</sub> up to a maximum of 6 GHz				

NOTE 1 For FM and TV broadcast receivers,  $F_x$  is determined from the highest frequency generated or used excluding the local oscillator and tuned frequencies.

NOTE 2 F<sub>x</sub> is highest fundamental frequency generated or used within the EUT or highest frequency at which it operates.

Where F<sub>x</sub> is unknown, the radiated emission measurements shall be performed up to 6 GHz.



# 8.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Spectrum	E4446A	MY51100009	Jun. 6, 2019	Jun. 5, 2020
Agilent Test Receiver	N9038A	MY50010135	May 29, 2019	May 28, 2020
Agilent Preamplifier	8449B	3008A01924	Feb. 21, 2019	Feb. 20, 2020
MITEQ Preamplifier	AMF-6F-260400-33-8P	892164	Feb. 21, 2019	Feb. 20, 2020
EMCI Preamplifier	EMC184045B	980235	Feb. 21, 2019	Feb. 20, 2020
ETS Preamplifier	3117-PA	00215857	Nov. 25, 2018	Nov. 24, 2019
Schwarzbeck Horn Antenna	BBHA-9170	212	Nov. 25, 2018	Nov. 24, 2019
EMCO Horn Antenna	3115	9312-4192	Nov. 25, 2018	Nov. 24, 2019
Max Full. Turn Table & Tower	MF7802	MF780208103	NA	NA
Software	Radiated_V8.7.08	NA	NA	NA
SUHNER RF cable With 3/4dB PAD	SF102	Cable-CH7-3.6m	Jul. 10, 2019	Jul. 9, 2020
MICRO-TRONICS Notch filter	BRC50703-01	010	May 30, 2019	May 29, 2020
MICRO-TRONICS Band Pass Filter	BRM17690	005	May 30, 2019	May 29, 2020

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The 3dB beamwidth of the horn antenna is minimum 40 degree (or w = 2.18m at 3m distance) for 1~6 GHz.
- 3. The test was performed in Chamber No. 7.
- 4. The VCCI Site Registration No. G-10039
- 5. Tested Date: Aug. 29, 2019

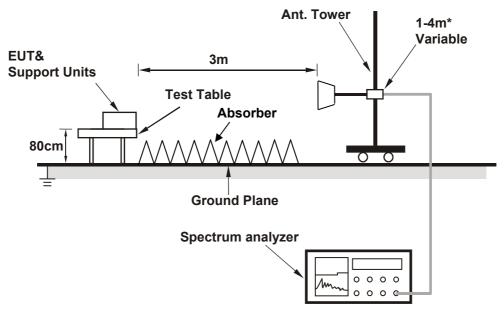


### 8.3 Test Arrangement

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at an accredited chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The spectrum analyzer system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

#### Note:

- The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.
- 2. The measurement distance is the shortest horizontal distance between an imaginary circular periphery just encompassing this arrangement and the calibration point of the antenna.



Note: Cable on the RGP must to be insulated.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

<sup>\*:</sup> depends on the EUT height and the antenna 3dB beamwidth both.

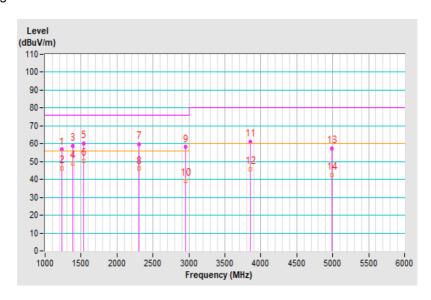


## 8.4 Test Results

Frequency Range	1GHz ~ 6GHz	Detector Function & Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested by	Chin-Wen Wang	Environmental Conditions	22°C, 68%RH, 1001mbar
Test Mode	Mode 1		

	Antenna Polarity & Test Distance : Horizontal at 3 m									
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)		
1	1231.93	56.70 PK	76.00	-19.30	1.81 H	360	59.51	-2.81		
2	1231.93	46.28 AV	56.00	-9.72	1.81 H	360	49.09	-2.81		
3	1385.88	58.64 PK	76.00	-17.36	1.87 H	52	61.51	-2.87		
4	1385.88	48.88 AV	56.00	-7.12	1.87 H	52	51.75	-2.87		
5	1539.90	60.07 PK	76.00	-15.93	2.29 H	131	62.36	-2.29		
6	1539.90	50.52 AV	56.00	-5.48	2.29 H	131	52.81	-2.29		
7	2309.84	59.89 PK	76.00	-16.11	1.32 H	135	58.57	1.32		
8	2309.84	46.00 AV	56.00	-10.00	1.32 H	135	44.68	1.32		
9	2950.92	58.09 PK	76.00	-17.91	1.37 H	231	54.72	3.37		
10	2950.92	39.17 AV	56.00	-16.83	1.37 H	231	35.80	3.37		
11	3849.65	61.00 PK	80.00	-19.00	1.73 H	46	56.27	4.73		
12	3849.65	45.89 AV	60.00	-14.11	1.73 H	46	41.16	4.73		
13	4992.80	57.47 PK	80.00	-22.53	1.92 H	284	50.55	6.92		
14	4992.80	42.34 AV	60.00	-17.66	1.92 H	284	35.42	6.92		

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
  - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value

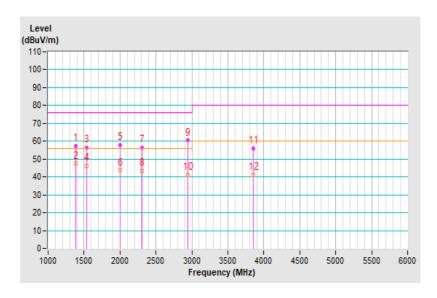




Frequency Range	1GHz ~ 6GHz	Detector Function & Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested by	Chin-Wen Wang	Environmental Conditions	22°C, 68%RH, 1001mbar
Test Mode	Mode 1		

	Antenna Polarity & Test Distance : Vertical at 3 m							
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1385.94	57.42 PK	76.00	-18.58	1.87 V	152	60.29	-2.87
2	1385.94	47.31 AV	56.00	-8.69	1.87 V	152	50.18	-2.87
3	1539.90	56.50 PK	76.00	-19.50	2.29 V	135	58.79	-2.29
4	1539.90	46.05 AV	56.00	-9.95	2.29 V	135	48.34	-2.29
5	2001.93	58.01 PK	76.00	-17.99	1.90 V	170	57.11	0.90
6	2001.93	43.60 AV	56.00	-12.40	1.90 V	170	42.70	0.90
7	2309.97	56.39 PK	76.00	-19.61	1.32 V	360	55.07	1.32
8	2309.97	43.48 AV	56.00	-12.52	1.32 V	360	42.16	1.32
9	2939.93	60.37 PK	76.00	-15.63	1.29 V	166	57.08	3.29
10	2939.93	41.12 AV	56.00	-14.88	1.29 V	166	37.83	3.29
11	3849.47	55.88 PK	80.00	-24.12	1.73 V	80	51.15	4.73
12	3849.47	40.94 AV	60.00	-19.06	1.73 V	80	36.21	4.73

- 1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
- 2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB)
  - Pre-Amplifier Factor (dB)
- 3. The other emission levels were very low against the limit.
- 4. Margin value = Emission level Limit value





### 9 Harmonics Current Measurement

### 9.1 Limits

Limits for Class A equipment		Limits for Class D equipment					
Harmonic Order	Max. permissible harmonics current	Harmonic Order	Max. permissible harmonics current per	Max. permissible harmonics current			
n	A	n	watt mA/W	Α			
C	odd harmonics		Odd Harmonics only				
3	2.30	3	3.4	2.30			
5	1.14	5	1.9	1.14			
7	0.77	7	1.0	0.77			
9	0.40	9	0.5	0.40			
11	0.33	11	0.35	0.33			
13	0.21	13	0.30	0.21			
15≦n≦39	0.15 x 15/n	15≦n≦39	3.85/n	0.15 x 15/n			
E	ven harmonics						
2	1.08						
4	0.43						
6	0.30						
8≦n≦40	0.23 x 8/n						

Notes: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

2. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

### 9.2 Classification of Equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment;	Portable tools;	Lighting	Equipment having a specified
Household appliances excluding	Arc welding	equipment.	power less than or equal to 600
equipment as Class D; Tools excluding portable tools;	equipment which is not professional		W of the following types: Personal computers and
Dimmers for incandescent lamps;	equipment.		personal computer monitors;
Audio equipment;	- oquipinonii		Television receivers;
Equipment not specified in one of the			Refrigerators and freezers
three other classes.			having one or more
			variable-speed drives to control
			compressor motor(s).

### 9.3 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 27, 2018	Sep. 26, 2019
Software	CTS 4	NA	NA	NA

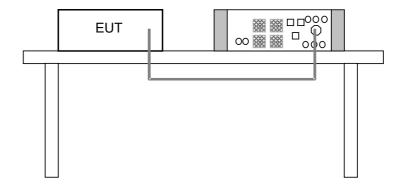
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 1.
- 3. According to IEC 61000-4-7: 2002, the time window shall be synchronized with each group of 10 or 12 cycles (200 ms)for power frequency of 50 or 60Hz.
- 4. Tested Date: Sep. 3, 2019



#### 9.4 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### 9.5 Test Results

	230.46Vrms/ 0.240Arms	Power Frequency	49.96Hz
Power Consumption	36.2W	Power Factor	0.700
Environmental Conditions	26 °C, 61%RH	Tested by	Aga Lin
Test Mode	Mode 1		

Note: 1. Limits are not specified for equipment with a rated power of 75W or less (other than lighting equipment).

2. According to EN 61000-3-2 the manufacturer shall specify the power of the apparatus. This value shall be used for establishing limits. The specified power shall be within +/-10% of the measured power.



### 10 Voltage Fluctuations and Flicker Measurement

#### 10.1 Limits

Test item	Limit	Note
P <sub>st</sub>	1.0	P <sub>st:</sub> short-term flicker severity.
Plt	0.65	P <sub>lt:</sub> long-term flicker severity.
T <sub>max</sub> (ms)	500	$T_{\text{max:}}$ maximum time duration during the observation period that the voltage deviation d(t) exceeds the limit for d <sub>c</sub> .
d <sub>max</sub> (%)	4	d <sub>max:</sub> maximum absolute voltage change during an observation period.
d <sub>c</sub> (%)	3.3	d₀: maximum steady state voltage change during an observation period.

## 10.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Profline 2105	32A00983 & 1639A01863	Sep. 27, 2018	Sep. 26, 2019
Software	CTS 4	NA	NA	NA

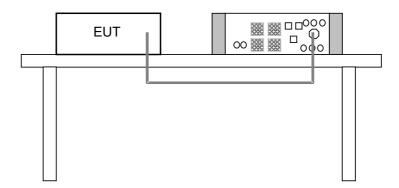
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1.

3. Tested Date: Sep. 3, 2019

### 10.3 Test Arrangement

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Report No.: CE190815D12 Page No. 38 / 73 Report Format Version: 6.1.3



### 10.4 Test Results

Fundamental Voltage/Ampere	230.46 Vrms / 0.240 Arms	Power Frequency	49.96 Hz
Observation (T <sub>p</sub> )	10 min.	Power Factor	0.700
Environmental Conditions	26°C, 61 % RH	Tested by	Aga Lin
Test Mode	Mode 1		

Test Parameter	Measurement Value	Limit	Remarks
P <sub>st</sub>	0.064	1.00	Pass
P <sub>lt</sub>	0.028	0.65	Pass
T <sub>max</sub> (ms)	0	500	Pass
d <sub>max</sub> (%)	0	4	Pass
d <sub>c</sub> (%)	0	3.3	Pass

Note: (1) P<sub>st</sub> means short-term flicker indicator.

- (2) P<sub>It</sub> means long-term flicker indicator.
  (3) T<sub>max</sub> means accumulated time value of d(t) with a deviation exceeding 3.3 %.
  (4) d<sub>max</sub> means maximum relative voltage change.
- (5) d<sub>c</sub> means maximum relative steady-state voltage change.



## 11 General Immunity Requirements

EN 5502	24:2010/ EN55024:2	010 +A1	:2015, Immunity requirements	
Clause	Reference standard	Table	Test specification	Performance Criterion
4.2.1	EN/IEC 61000-4-2 ESD	1.3	Enclosure port: ±8kV Air discharge, ±4kV Contact discharge	В
4.2.3.2	EN/IEC 61000-4-3 RS	1.2	Enclosure port: 80-1000 MHz, 3V/m, 80% AM (1kHz)	Α
4.2.2	EN/IEC 61000-4-4	2.3	Signal ports and telecommunication ports: xDSL equipment: ±0.5kV, 5/50 (T <sub>r</sub> /T <sub>h</sub> ) ns, 100kHz others: ±0.5kV, 5/50 (T <sub>r</sub> /T <sub>h</sub> ) ns, 5kHz	В
	EFT	3.3	Input DC power port: ±0.5kV, 5/50 (T <sub>r</sub> /T <sub>h</sub> ) ns, 5kHz	2
		4.5	Input AC Power ports: ±1kV, 5/50 (T <sub>r</sub> /T <sub>h</sub> ) ns, 5kHz	
		2.2	Signal and telecommunication ports (direct to outdoor cables): 10/700 (5/320) (T <sub>r</sub> /T <sub>h</sub> ) µs w/o primary protectors: ±1kV, or with primary protectors fitted: ±4kV	С
4.2.5	.5 EN/IEC 61000-4-5 Surge		Input DC power port (direct to outdoor cables): 1.2/50 (8/20) (T <sub>r</sub> /T <sub>h</sub> ) µs Line to earth: ±0.5kV	_
		4.4	Input AC Power ports: 1.2/50 (8/20) (T <sub>r</sub> /T <sub>h</sub> ) μs, Line to line: ±1kV Line to earth: ±2kV	В
		2.1	Signal and telecommunication ports(cable length > 3m): 0.15-80 MHz, 3V, 80% AM (1kHz)	
4.2.3.3	EN/IEC 61000-4-6 CS	3.1	Input DC power port: 0.15-80 MHz, 3V, 80% AM (1kHz)	Α
		4.1	Input AC Power ports: 0.15-80 MHz, 3V, 80% AM (1kHz)	
4.2.4	EN/IEC 61000-4-8 PFMF	1.1	Enclosure port: 50 or 60 Hz, 1A/m	Α
4.2.6	EN/IEC 61000-4-11	4.2	Input AC Power ports:  Voltage Dips:  >95% reduction – 0.5 period  30% reduction – 25 periods	B C
Dips & Interruptions		4.3	Input AC Power ports:  Voltage Interruptions:  >95% reduction – 250 periods	С



#### 11.1 Performance Criteria

#### **General Performance Criteria**

#### Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

#### Particular performance criteria

The particular performance criteria which are specified in the normative annexes of EN 55024 take precedence over the corresponding parts of the general performance criteria. Where particular performance criteria for specific functions are not given, then the general performance criteria shall apply.



#### 12 Electrostatic Discharge Immunity Test (ESD)

#### 12.1 Test Specification

**Basic Standard:** EN/IEC 61000-4-2 **Discharge Impedance:** 330 ohm / 150 pF

**Discharge Voltage:** Air Discharge: ±2, ±4, ±8kV (Direct)

Contact Discharge: ±2, ±4kV (Direct/Indirect)

**Number of Discharge:** Air – Direct: 10 discharges per location (each polarity)

Contact - Direct & Indirect: 25 discharges per location (each polarity) and

min. 200 times in total

Discharge Mode: Single Discharge Discharge Period: 1-second minimum

#### 12.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, ESD Simulator	MZ-15/EC	0504259	Nov. 12, 2018	Nov. 11, 2019

Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. The test was performed in ESD Room No. 1.
- 3. Tested Date: Sep. 10, 2019

### 12.3 Test Arrangement

The discharges shall be applied in two ways:

a. Contact discharges to the conductive surfaces and coupling planes:

The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

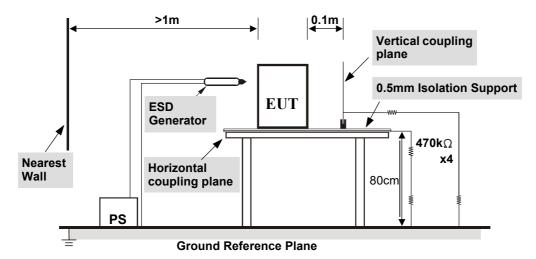
b. Air discharges at slots and apertures and insulating surfaces:

On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.



The basic test procedure was in accordance with EN/IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **V**ertical **C**oupling **P**lane in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.



## TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the **G**round **R**eference **P**lane. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **H**orizontal **C**oupling **P**lane (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with  $940k\Omega$  total impedance. The equipment under test, was installed in a representative system as described in section 7 of

EN/IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



### 12.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Michael Cheng
Environmental Conditions	22 °C, 50% RH 1001 mbar	Test mode	Mode 1

	Test Results of Direct Application						
Discharge Polarity Level (kV) (+/-) Test Point Contact Discharge Air Discharge Criterion							
2, 4	2, 4 +/- 1-4 Note 1 NA A						
2, 4	+/-	5-12	NA	Note 1	Α		
8	+/-	5-12	NA	Note 2	В		

Description of test points of direct application: Please refer to following page for representative mark only.

Test Results of Indirect Application						
Discharge Level (kV)	o i lest Point i i i i i i i i i i i i i i i i i i					
2, 4	+/-	Four Sides	Note 1	Note 1	Α	

Description of test points of indirect application:

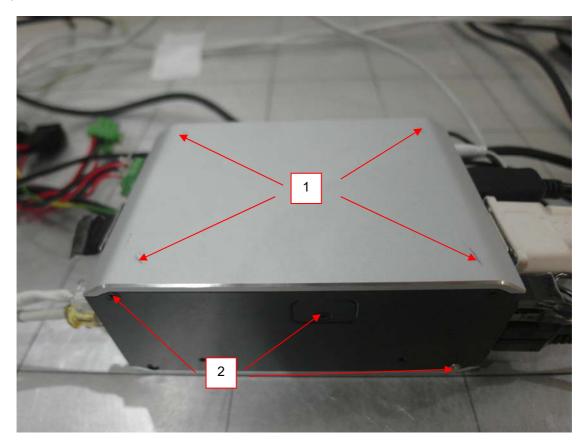
- 1. Front side
- 2. Rear side
- 3. Right side
- 4. Left side

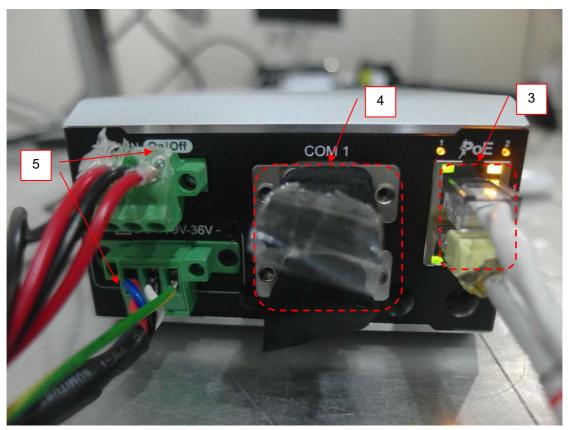
Note: 1. The EUT function was correct during the test.

2. The image on screen disappeared during the test, but self-recoverable after the test.

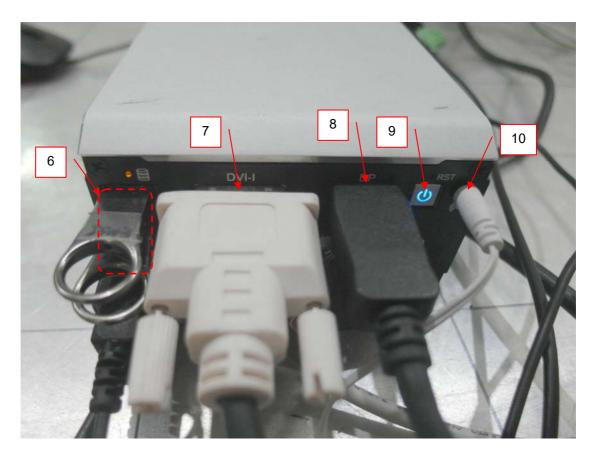


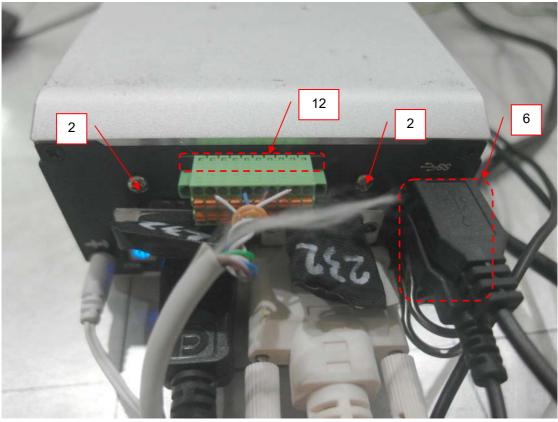
## Description of Test Points

















## 13 Radiated, Radio-frequency, Electromagnetic Field Immunity Test (RS)

### 13.1 Test Specification

Basic Standard: EN/IEC 61000-4-3 Frequency Range: 80 MHz - 1000 MHz

Field Strength: 3 V/m

Modulation: 1kHz Sine Wave, 80%, AM Modulation Frequency Step: 1 % of preceding frequency value

Polarity of Antenna: Horizontal and Vertical

Antenna Height: 1.5m

Dwell Time: 3 seconds

### 13.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
BONN Power Amp	BLMA 1060-100/50D	118694	NA	NA
BBA Power Amp	B250C125	101011	NA	NA
Power Sensor	NRP-Z91	101572	Jan. 24, 2019	Jan. 23, 2020
Power Sensor	NRP-Z91	101573	Jan. 18, 2019	Jan. 17, 2020
Signal Generator	SMB100A	105801	Jan. 17, 2019	Jan. 16, 2020
R&S Software	EMC32 Version 8.52.0	NA	NA	NA
Stacked Log-Per Antenna	STLP9149	9149-141	NA	NA
High GAIN LOG-Periodic Antenna	HL046E	100114	NA	NA

Note: 1. The test was performed in Hwa Ya RS Room 2.

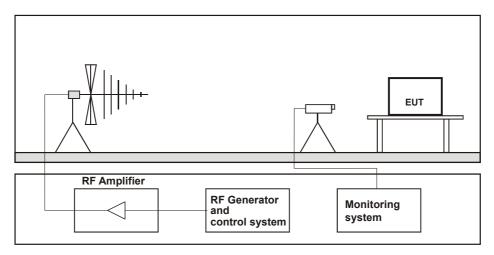
- 2. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 3. The transmit antenna was located at a distance of 3 meters from the EUT.
- 4. Tested Date: Sep. 20, 2019



#### 13.3 Test Arrangement

The test procedure was in accordance with EN/IEC 61000-4-3.

- a. The testing was performed in a fully anechoic chamber.
- b. The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1kHz sine wave.
- c. The field strength level was 3 V/m.
- d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



### Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 13.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Regan Wang
Environmental Conditions	23 °C, 68% RH	Test mode	Mode 1

Fraguenov (MHz)	Dolority	Azimuth(°)	Applied	d Field Strength	Observation	Performance
Frequency (MHz)	Polarity	Azimuth(°)	(V/m)	Modulation	Observation	Criterion
80 -1000	V&H	0	3	80% AM (1kHz)	Note	Α
80 -1000	V&H	90	3	80% AM (1kHz)	Note	Α
80 -1000	V&H	180	3	80% AM (1kHz)	Note	Α
80 -1000	V&H	270	3	80% AM (1kHz)	Note	Α

Note: The EUT function was correct during the test.



### 14 Electrical Fast Transient/Burst Immunity Test (EFT)

#### 14.1 Test Specification

Basic Standard: EN/IEC 61000-4-4

Test Voltage: Signal / telecommunication port: ±0.5kV

Input DC power port: N/A
Input AC power port: ±1kV

Impulse Repetition Frequency: xDSL telecommunication port: 100kHz

others: 5kHz

Impulse Wave Shape: 5/50 ns

Burst Duration: 0.75 ms for 100kHz Repetition Frequency

15 ms for 5kHz Repetition Frequency

Burst Period: 300 ms Test Duration: 1 min.

#### 14.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Haefely, EFT Generator	PEFT 4010	154954	Apr. 23, 2019	Apr. 22, 2020
Haefely,Capacitive Clamp	IP4A	155173	Apr. 23, 2019	Apr. 22, 2020

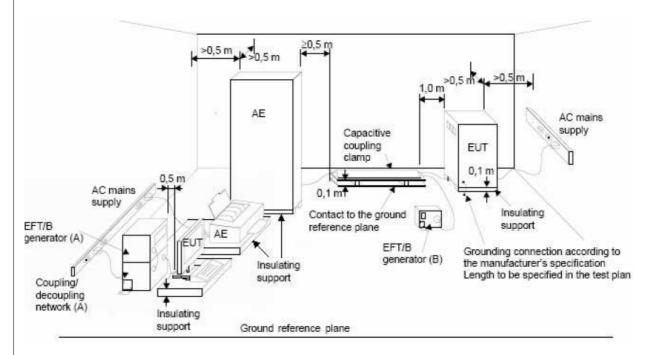
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EFT Room.
- 3. Tested Date: Sep. 3, 2019



#### 14.3 Test Arrangement

- a. Both positive and negative polarity discharges were applied.
- b. The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- c. The duration time of each test sequential was 1 minute.
- d. The transient/burst waveform was in accordance with EN/IEC 61000-4-4, 5/50 ns.



#### NOTE:

- (A) location for supply line coupling
- (B) location for signal lines coupling

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

#### 14.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Aga Lin
Environmental Conditions	24°C, 63% RH	Test mode	Mode 1

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
1	L1	+/-	Note	Α
1	L2	+/-	Note	Α
1	PE	+/-	Note	Α
1	L1-L2-PE	+/-	Note	Α

Telecommunication port

	Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
ĺ	0.5	LAN	+/-	Note	Α

Note: The EUT function was correct during the test.



#### 15 Surge Immunity Test

### 15.1 Test Specification

Basic Standard: EN/IEC 61000-4-5

Wave-Shape: Signal / telecommunication port (direct to outdoor cables\*):

10/700 μs Open Circuit Voltage 5/320 μs Short Circuit Current

Input DC power port (direct to outdoor cables\*):

1.2/50 µs Open Circuit Voltage 8/20 µs Short Circuit Current

Input AC power port:

1.2/50 µs Open Circuit Voltage 8/20 µs Short Circuit Current

Test Voltage: Signal and telecommunication ports\*\*:

w/o primary protectors: N/A, with primary protectors fitted: N/A

Input DC power port: Line to earth or ground:N/A

Input AC power ports: Line to line: ±0.5kV, ±1kV,

Line to earth or ground: ±0.5kV, ±1kV, ±2kV

AC Phase Angle (degree): 0°, 90°, 180°, 270° Pulse Repetition Rate: 1 time / 20 sec.

Number of Tests: 5 positive and 5 negative at selected points

\* This test is only applicable only to ports, which according to the manufacturer's specification, may connect directly to outdoor cables.

#### 15.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ, Surge Simulator	NSG 3060	1572	May 22, 2019	May 21, 2020
Coupling Decoupling Network	CDN-UTP8	045	Aug. 27, 2019	Aug. 26, 2020
TESEQ Coupling Decoupling Network	CDN HSS-2	41009	May 22, 2019	May 21, 2020
TESEQ Coupling Decoupling Network	CDN 118-T8	40386	Sep. 20, 2018	Sep. 19, 2019
TESEQ CDN for Unshielded Unsymmetrical Signal & Data Lines	CDN117	40144	Sep. 20, 2018	Sep. 19, 2019

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in EMS Room No. 2.
- 3. Tested Date: Sep. 5, 2019

<sup>\*\*</sup> For ports where primary protection is intended, surges are applied at voltages up to 4 kV with the primary protectors fitted. Otherwise the 1 kV test level is applied without primary protection in place.



### 15.3 Test Arrangement

a. Input AC/DC Power ports:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

- b. Signal and telecommunication ports,
  - Unshielded unsymmetrical interconnection lines:

The surge is applied to the lines via the capacitive coupling. The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

• Unshielded symmetrical interconnections communication lines:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length.

High speed communications lines

Prior to the test, the correct operation of the port shall be verified; the external connection shall then be removed and the surge applied directly to the port's terminals with no coupling /decoupling network. After the surge, the correct operation of the port shall again be verified.

- Shielded lines:
  - Direct application,

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with single or multiple shielded cables.

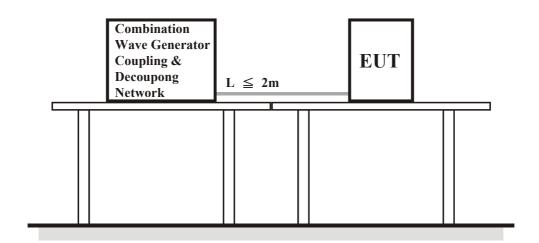
Rules for application of the surge to shielded lines:

- a) Shields grounded at both ends
  - The surge injection on the shield.
- b) Shields grounded at one end
  - If in the installation the shield is connected only at the auxiliary equipment, test shall be done in that configuration but with the generator still connected to the EUT side. If cable lengths allow, the cables shall be on insulated supports 0,1 m above the ground plane or cable tray.

For products which do not have metallic enclosures, the surge is applied directly to the shielded cable.

- Alternative coupling method for testing single cables in a multi-shield configuration, Surges are applied in close proximity to the interconnection cable under test by a wire. The length of the cable between the port(s) under test and the device attached to the other end of the cable shall be the lesser of: the maximum length permitted by the EUT's specification, or 20 m. Where the length exceeds 1 m, excess lengths of cables shall be bundled at the approximate centre of the cables with the bundles 30 cm to 40 cm in length.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### 15.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	25 °C, 70% RH	Test mode	Mode 1

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criterion
0.5, 1	L1-L2	+/-	Note	Α
0.5, 1, 2	L1-PE	+/-	Note	Α
0.5, 1, 2	L2-PE	+/-	Note	Α

Note: The EUT function was correct during the test.



### 16 Immunity to Conducted Disturbances Induced by RF Fields (CS)

## 16.1 Test Specification

Basic Standard: EN/IEC 61000-4-6 Frequency Range: 0.15 MHz - 80 MHz

Voltage Level: 3 V

Modulation: 1kHz Sine Wave, 80%, AM Modulation Frequency Step: 1 % of preceding frequency value

Dwell Time 3 seconds

#### 16.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ Signal Generator	SML03	101801	Jan. 14, 2019	Jan. 13, 2020
Digital Sweep Function Generator	8120	984801	NA	NA
AR Power Amplifier	75A250AM1	306331	NA	NA
FCC Coupling Decoupling Network	FCC-801-M2-16A	01047	Jun. 19, 2019	Jun. 18, 2020
FISCHER CUSTOM COMMUNICATIONS EM Injection Clamp	F-203I-23mm	455	NA	NA
FISCHER CUSTOM COMMUNICATIONS Current Injection Clamp	F-120-9A	361	Jul. 31, 2019	Jul. 30, 2020
B&K Ear Simulator	4185	2553594	NA	NA
EM TEST Coupling Decoupling Network	CDN M1/32A	306508	Jun. 19, 2019	Jun. 18, 2020
TESEQ Coupling Decoupling Network	CDN T800	34428	Jun. 19, 2019	Jun. 18, 2020
TESEQ Coupling Decoupling Network	CDN T800	29459	Jun. 19, 2019	Jun. 18, 2020
FCC Coupling Decoupling Network	FCC-801-T4	02031	Jun. 19, 2019	Jun. 18, 2020
EM TEST Coupling Decoupling Network	CDN T2	306509	Jun. 19, 2019	Jun. 18, 2020
R&S Power Sensor	NRV-Z5	837878/039	Nov. 10, 2018	Nov. 9, 2019
R&S Power Meter	NRVD	837794/040	Nov. 10, 2018	Nov. 9, 2019
TESEQ Coupling Decoupling Network	CDN M232	37702	Jun. 19, 2019	Jun. 18, 2020
TESEQ Coupling Decoupling Network	CDN M332	41258	Jun. 19, 2019	Jun. 18, 2020
TESEQ Coupling Decoupling Network	CDN M332	41256	Jun. 19, 2019	Jun. 18, 2020
TESEQ Coupling Decoupling Network	CDN T8-10	40376	Jun. 19, 2019	Jun. 18, 2020
TESEQ Coupling Decoupling Network	ISN ST08	41212	Jun. 19, 2019	Jun. 18, 2020
FCC Coupling Decoupling Network	FCC-801-M5-50A	100018	Jan. 21, 2019	Jan. 20, 2020
Software	CS_V7.4.2	NA	NA	NA

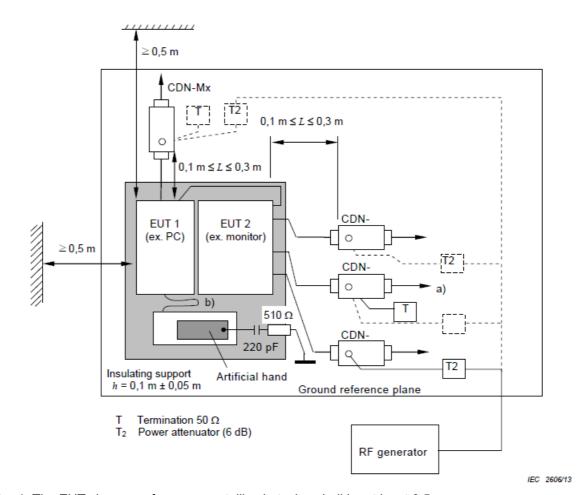
Note:

- 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. The test was performed in CS Room No. 1.
- 3. Tested Date: Sep. 5, 2019



#### 16.3 Test Arrangement

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- c. One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- d. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- e. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.



**Note:** 1. The EUT clearance from any metallic obstacles shall be at least 0,5 m.

- 2. Interconnecting cables (  $\leqq\!1$  m) belonging to the EUT shall remain on the insulating support.
- 3. The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 16.4 Test Results

Input Power	230 Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	24 °C, 72% RH	Test mode	Mode 1

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criterion
0.15 – 80	3	AC Power	CDN-M3	CDN-M1	Note	Α
0.15 – 80	3	LAN	CDN-T8	CDN-M3	Note	A

Note: The EUT function was correct during the test.



#### 17 Power Frequency Magnetic Field Immunity Test

### 17.1 Test Specification

Basic Standard: EN/IEC 61000-4-8

Frequency Range: 50Hz
Field Strength: 1 A/m
Observation Time: 1 minute

Inductance Coil: Rectangular type, 1 m x 1 m

#### 17.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
HAEFELY Magnetic Field Tester	MAG 100	083794-06	NA	NA
COMBINOVA Magnetic Field Meter	MFM10	224	Apr. 23, 2019	Apr. 22, 2020

Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1

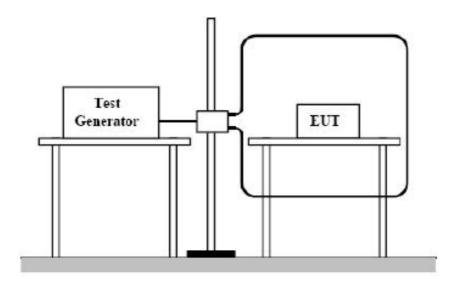
3. Tested Date: Sep. 3, 2019

### 17.3 Test Arrangement

a. The equipment is configured and connected to satisfy its functional requirements.

b. The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.

c. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



#### TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 17.4 Test Results

Ir	put Power	230 Vac, 50 Hz	Tested by	Aga Lin
Е	nvironmental Conditions	25 °C, 64% RH	Test mode	Mode 1

Application	Frequency (Hz)	Field Strength (A/m)	Observation	Performance Criterion
X - Axis	50	1	Note	Α
Y - Axis	50	1	Note	Α
Z - Axis	50	1	Note	A

Note: The EUT function was correct during the test.



#### 18 Voltage Dips and Interruptions

### 18.1 Test Specification

Basic Standard: EN/IEC 61000-4-11

Test levels: Voltage Dips:

>95% reduction – 0.5 period 30% reduction – 25 periods

Voltage Interruptions:

>95% reduction - 250 periods

Interval between Event: Minimum ten seconds

Sync Angle (degrees): 0° / 180° Test Cycle: 3 times

#### 18.2 Test Instruments

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Immunity Test System	Profline 2105	1632A00983 & 1639A01863	Jun. 19, 2019	Jun. 18, 2020
Software	WIN2120	NA	NA	NA

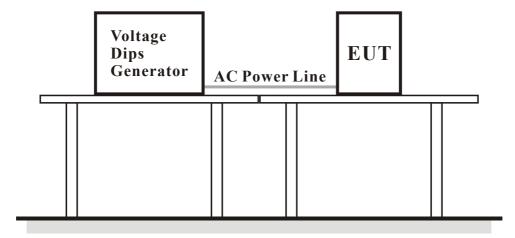
Note: 1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. The test was performed in EMS Room No. 1.

3. Tested Date: Sep. 3, 2019

### 18.3 Test Arrangement

The EUT shall be tested for each selected combination of test levels and duration with a sequence of 3 dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at 0 degree crossover point of the voltage waveform.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 18.4 Test Results

	230 Vac, 50 Hz 240 Vac, 50 Hz 100 Vac, 50 Hz	Tested by	Aga Lin
Environmental Conditions	25 °C, 64% RH	Test mode	Mode 1

Input Power for testing: 230 Vac, 50 Hz (Nominal input Voltage)						
Voltage Reduction (%)	Duration (period)	Interval (sec)	Times	Observation	Performance Criterion	
>95	0.5	10	3	Note 1	Α	
30	25	10	3	Note 1	Α	
>95	250	10	3	Note 2	В	

Input Power for testing: 240 Vac, 50 Hz (Maximum rated input voltage)						
Voltage Reduction (%)	Duration (period)	Times	Observation	Performance Criterion		
>95	0.5	10	3	Note 1	Α	
30	25	10	3	Note 1	Α	
>95	250	10	3	Note 2	В	

Input Power for testing: 100 Vac, 50 Hz (Minimum rated input voltage)						
Voltage Reduction (%)	Duration (period)	Times	Observation	Performance Criterion		
>95	0.5	10	3	Note 1	Α	
30	25	10	3	Note 1	Α	
>95	250	10	3	Note 2	В	

Note: 1. The EUT function was correct during the test.

 The power supply of EUT was changed from AC mains to battery during the test, but self-recoverable after the test.



## 19 Pictures of Test Arrangements

## 19.1 Conducted Emission from the AC Mains Power Port







# 19.2 Asymmetric Mode Conducted Emission at Telecommunication Ports







# 19.3 Radiated Emission at Frequencies up to 1GHz

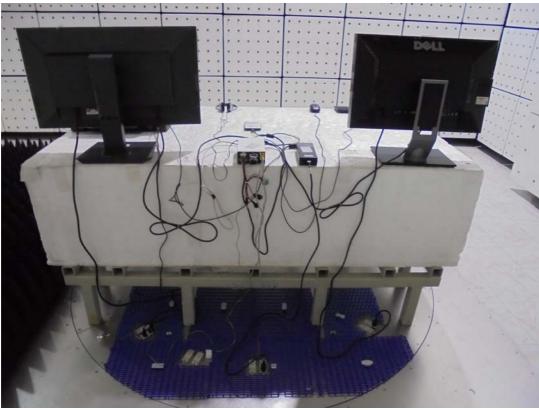






## 19.4 Radiated Emission at Frequencies above 1GHz







## 19.5 Harmonics Current, Voltage Fluctuations and Flicker Measurement



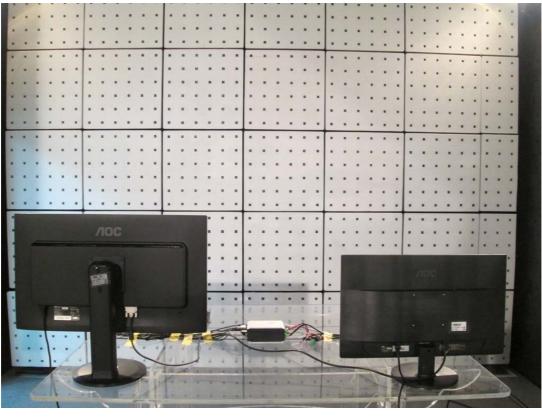
## 19.6 Electrostatic Discharge Immunity Test (ESD)





## 19.7 Radio-frequency, Electromagnetic Field Immunity Test (RS)







## 19.8 Electrical Fast Transient/Burst Immunity Test (EFT)

Mains ports









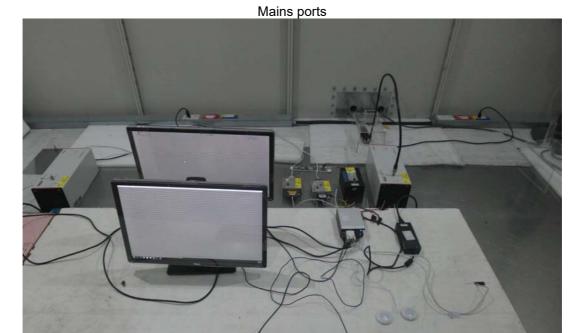
# 19.9 Surge Immunity Test

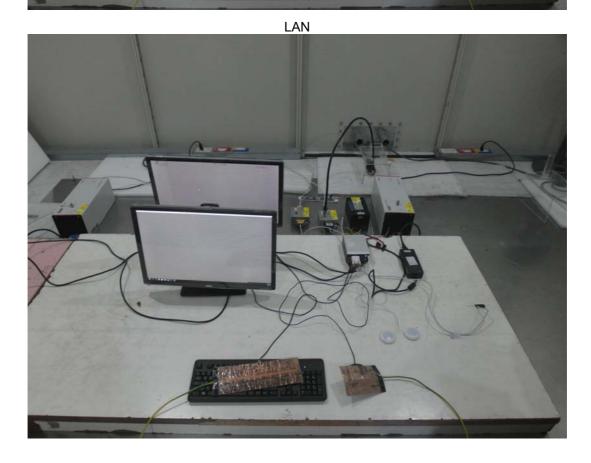






# 19.10 Conducted Disturbances Induced by RF Fields (CS)





Report No.: CE190815D12 Page No. 71 / 73 Report Format Version: 6.1.3



## 19.11 Power Frequency Magnetic Field Immunity Test (PFMF)



## 19.12 Voltage Dips and Interruptions





### Appendix - Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

Hsin Chu EMC/RF/Telecom Lab

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Tel: 886-3-3183232 Fax: 886-3-3270892

Email: <a href="mailto:service.adt@tw.bureauveritas.com">service.adt@tw.bureauveritas.com</a>
Web Site: <a href="mailto:www.bureauveritas-adt.com">www.bureauveritas-adt.com</a>

The address and road map of all our labs can be found in our web site also.

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